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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventor:

Thomas L. Davis

Filing Date:

September 16, 2003

For:

SYSTEM AND METHOD FOR FREQUENCY TRANSLATION

WITH HARMONIC SUPPRESSION USING MIXER STAGES

Mail Stop Patent Application Commissioner of Patents PO Box 1450 Alexandria, VA 22313-1450

Dear Sir:

INFORMATION DISCLOSURE STATEMENT

Applicant respectfully requests, pursuant to 37 C.F.R. §§ 1.56, 1.97 and 1.98, that the references listed on the attached PTO-1449 form be considered and cited in the examination of the above-identified patent application. No representation is made that a search has been made, that the references are material to the patentability of the present application, or that the references qualify as prior art.

Respectfully submitted,

Baker Botts L.L.P. Attorneys for Applicant

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Date:

September 16, 2003

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Customer No.

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TO-1449 Information Disclosure Citation In an Application			Application No. Unknown Docket Number 073897.0191 Group Art Unit Unknown		Applicant(s) Thomas L. Davis			
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